

Search Notes

Application/Control No.

10/709,952

Examiner

Matthew Heneghan

Applicant(s)/Patent under
Reexamination

BISHOP ET AL.

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IEEE, ACM Searches, see notes	7/8/2007	MH
EAST, keyword+class searches, see notes	7/8/2007	MH
Inventor Search	7/8/2007	MH